

Search Notes**Application/Control No.**

10/540,478

Examiner

Trinh T. Nguyen

**Applicant(s)/Patent under
Reexamination**

HOLMERTZ ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
updated	previous	5/3/2009	TTN
	searches		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR